

Methods of electronic structure mapping in real space

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Background: STM

History

1971 Topografiner: Russel D. Young

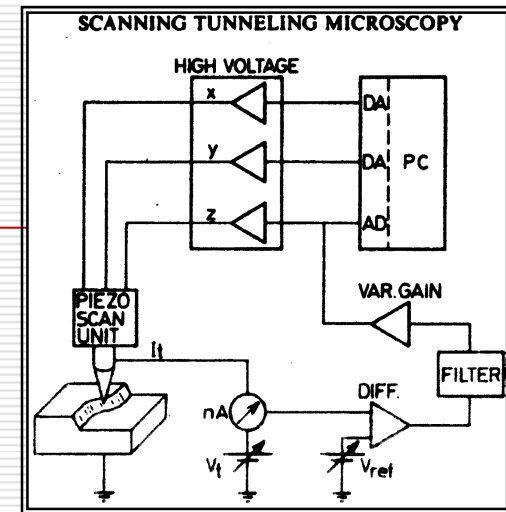
1981 STM: G. Binnig & H. Rohrer => Nobel Prize 1986

Properties of STM

- Small tunnel junction area, provides atomic resolution ..nanotechnology
- Primary measured quantity is total flux of electrons
- The tip height is regulated or *not* (topography or *current*)

Applications in surface science

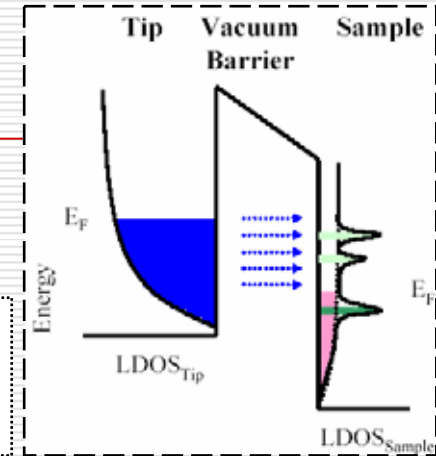
- Crystal surfaces: semiconductor, metal, etc.
- Adsorption of anorganic and organic materials
- Study of diffusion
- Nanomanipulation
- **Local** spectroscopies (LDOS, spin-resolved, workfunction, molecule vibrations, electroluminescence)



Electron spectroscopy

Basic expression:

$$dI/dV \propto \rho_{sample}(\vec{r}, E_F - eV) D(E_F - eV)$$

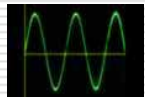


=> I-V or dI/dV measurement is crucial for LDOS mapping

Two elementary techniques:



digital dI/dV: an I-V curve taken in every “pixel” of scanning, derivative calculated



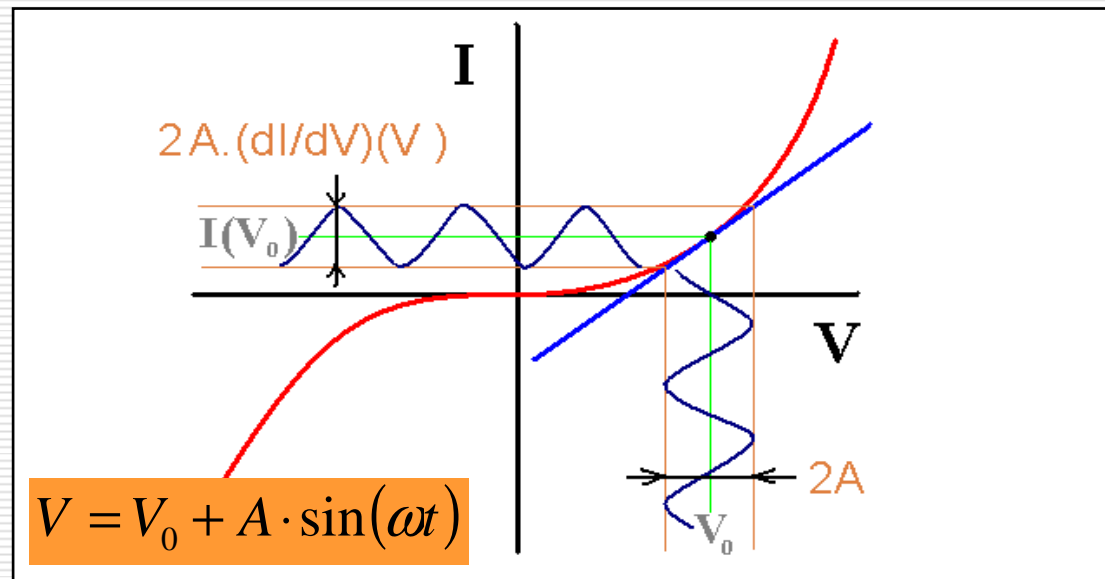
phase-sensitive **lock-in**: dI/dV retrieved directly without interrupting the scanning process

Note: In an ideal case, STS is comparable with photoemission valence band & inverse photoemission spectra

Lock-in technique

Response of the tunneling junction

response:



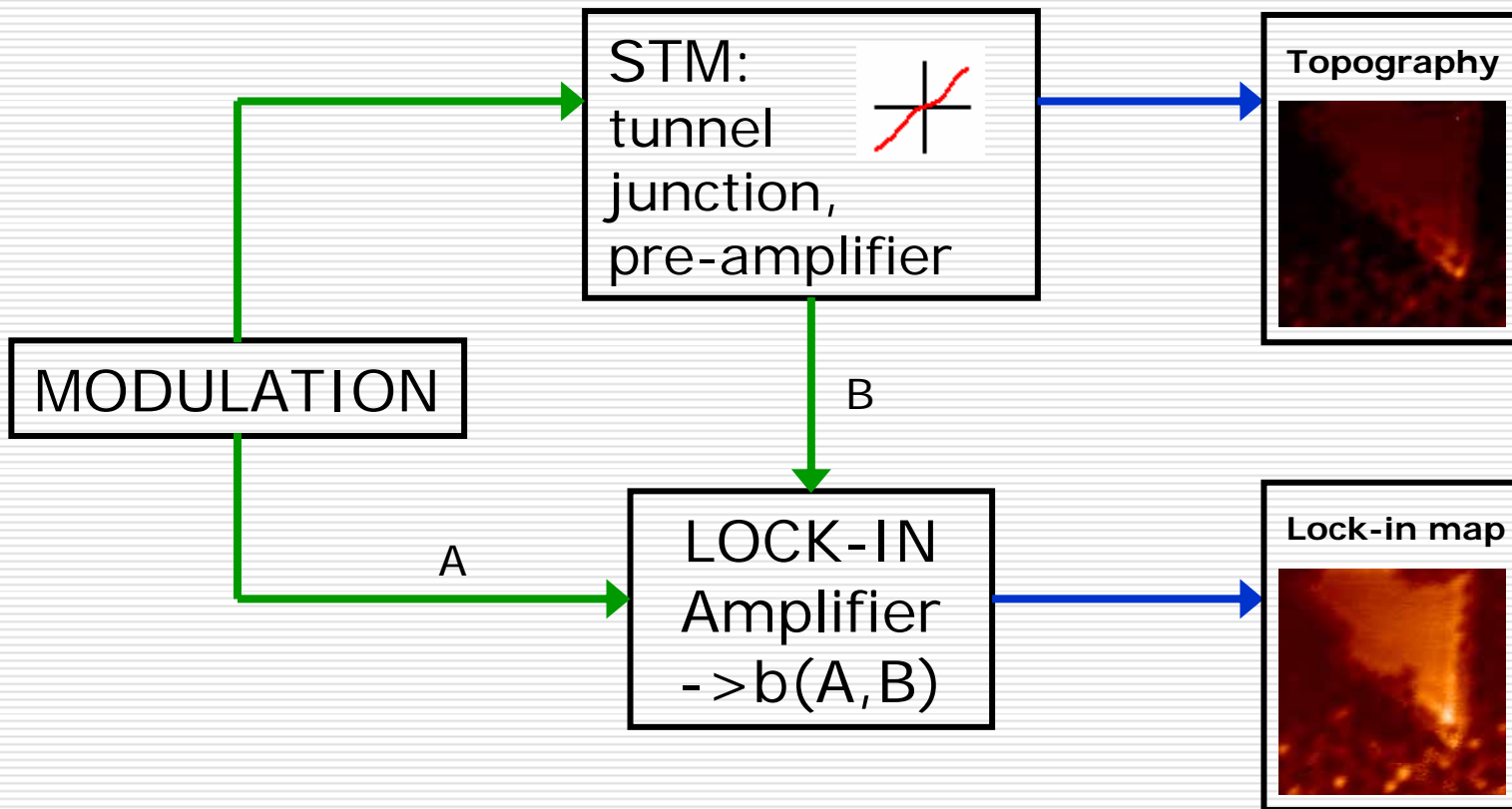
modulation:

$$V = V_0 + A \cdot \sin(\omega t)$$

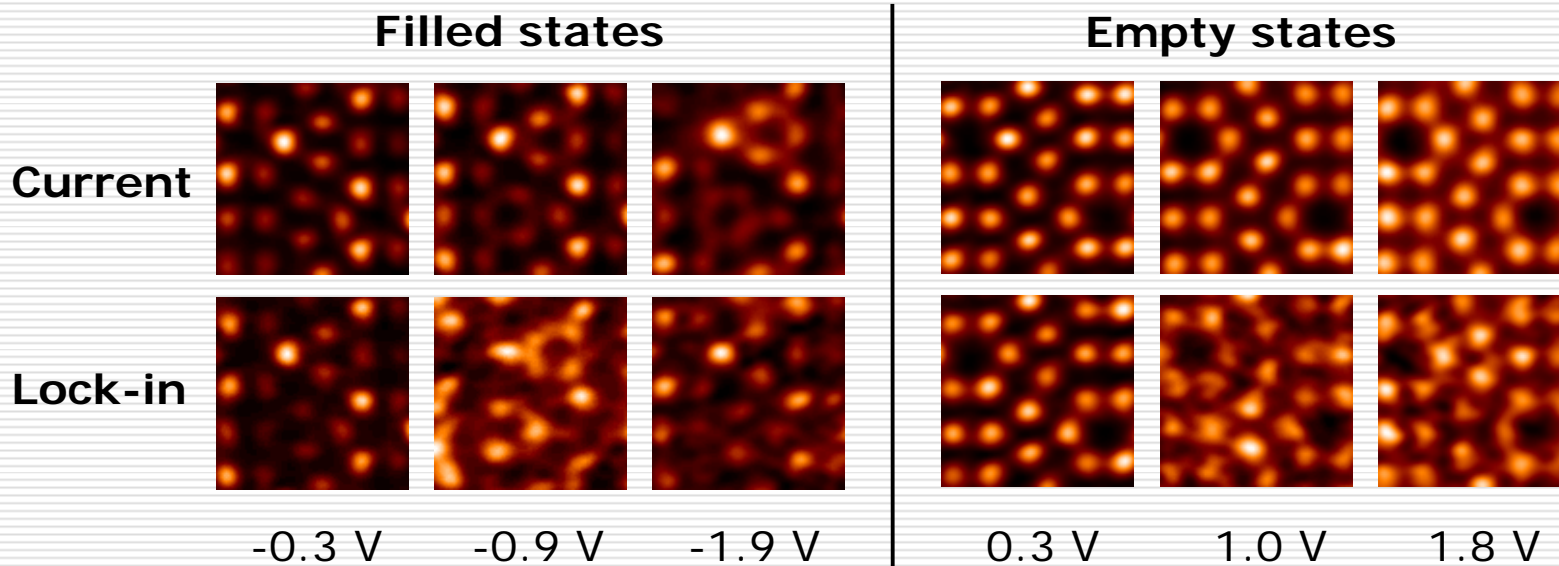
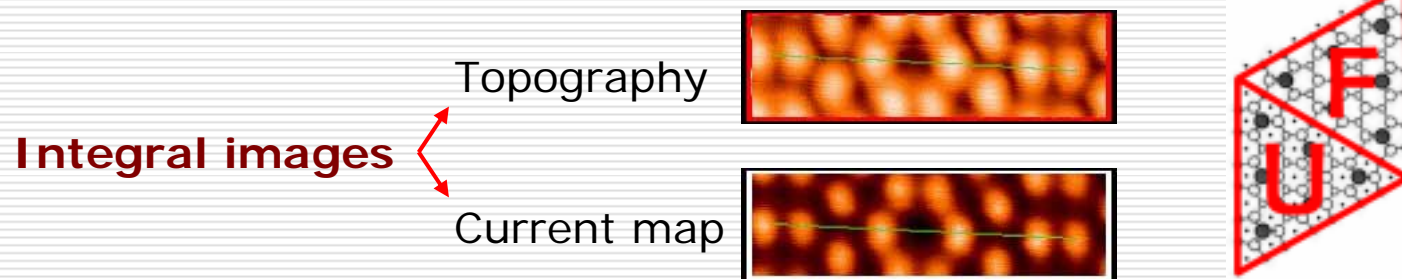
Taylor series of the response:

$$I(V) = I(V_0) + \left. \frac{dI}{dV} \right|_{V_0} \cdot A \cdot \sin(\omega t) + \left. \frac{d^2 I}{dV^2} \right|_{V_0} \cdot A^2 \cdot \frac{\cos(2\omega t)}{4} + \dots$$

Block diagram

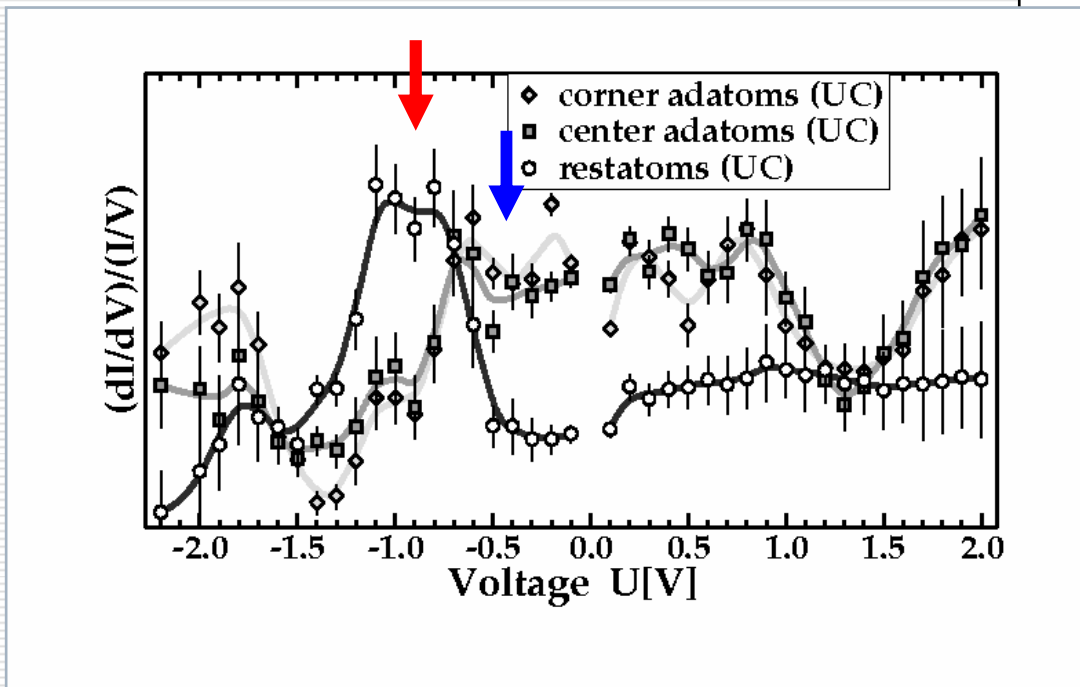


Examples: Si(111)-7x7

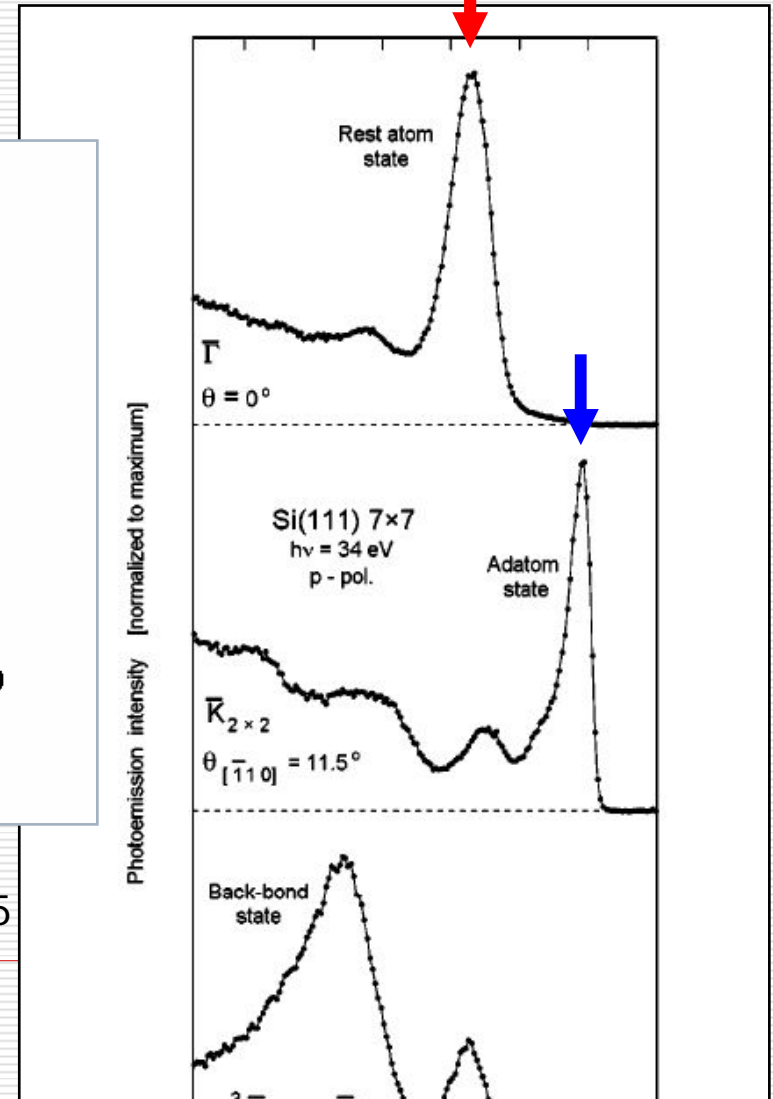


Examples: Si(111)-7x7

STS constructed of the lock-in maps



ARUPS: Losio et. al. Phys. Rev. B **61**, 10845

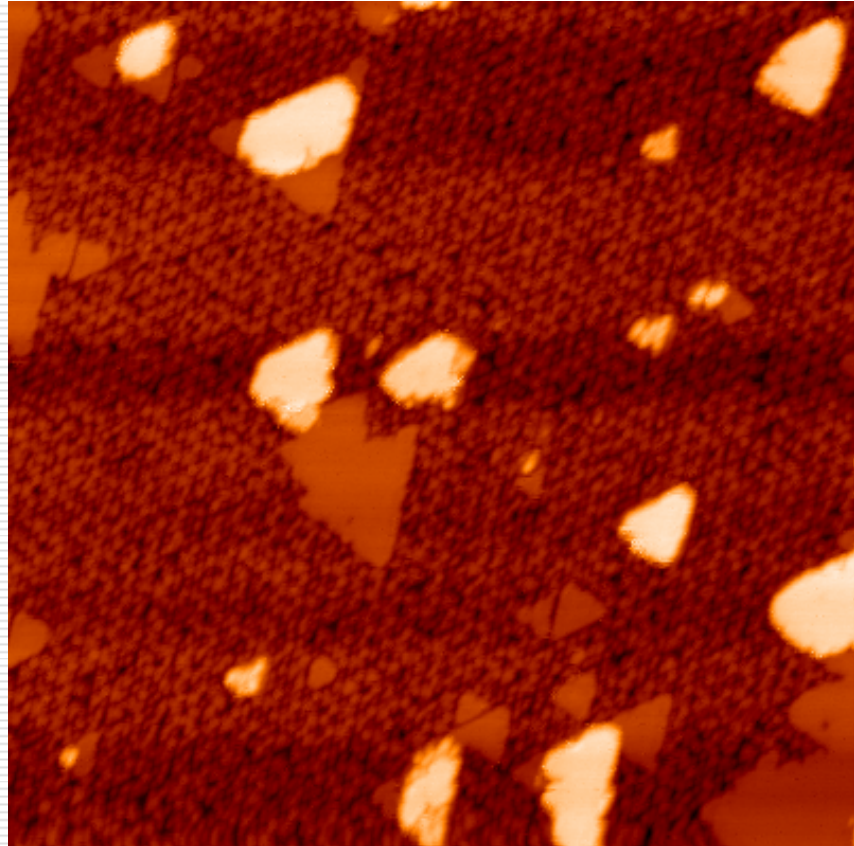


Pb/Si(111) < 1ML

Pb evaporation on Si(111)-
7x7 + heating up to 600K

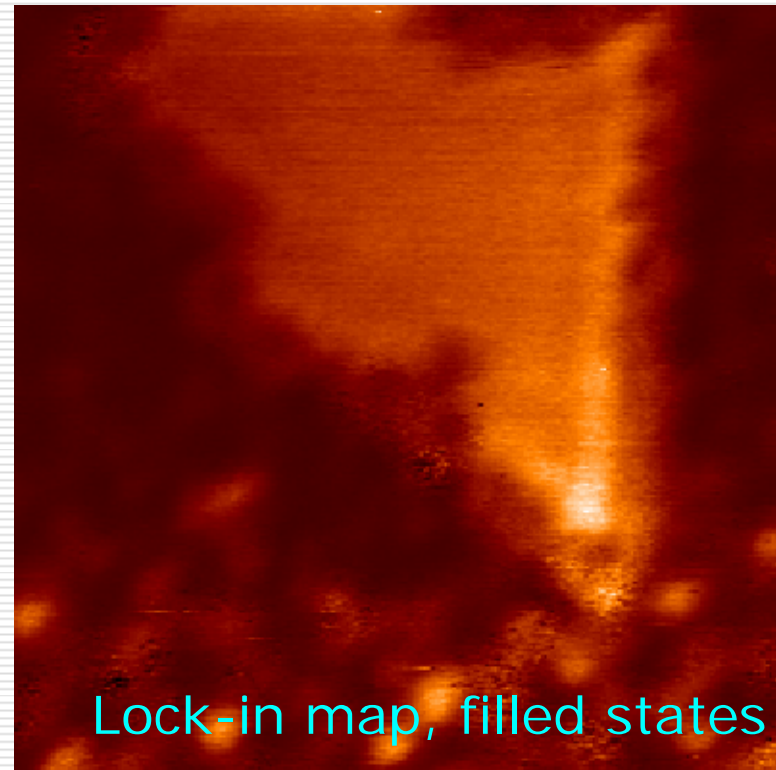
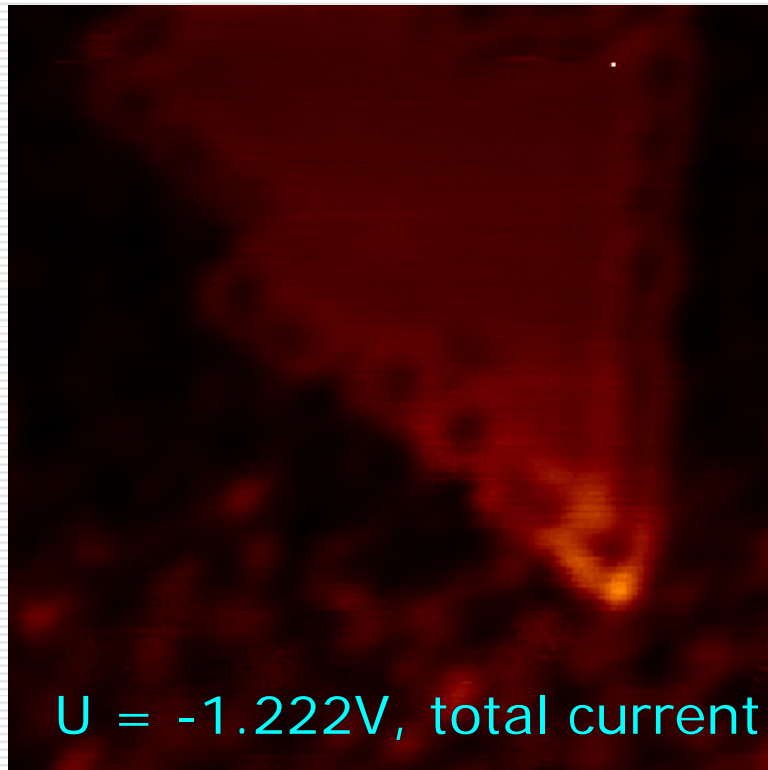
= incomplete layer
+ 1x1 islands

U=-1.1V, I=0.5nA,
standard topography,
size of 100x100 nm²



Pb/Si(111) < 1ML

1x1 islands: vanishing island boundary

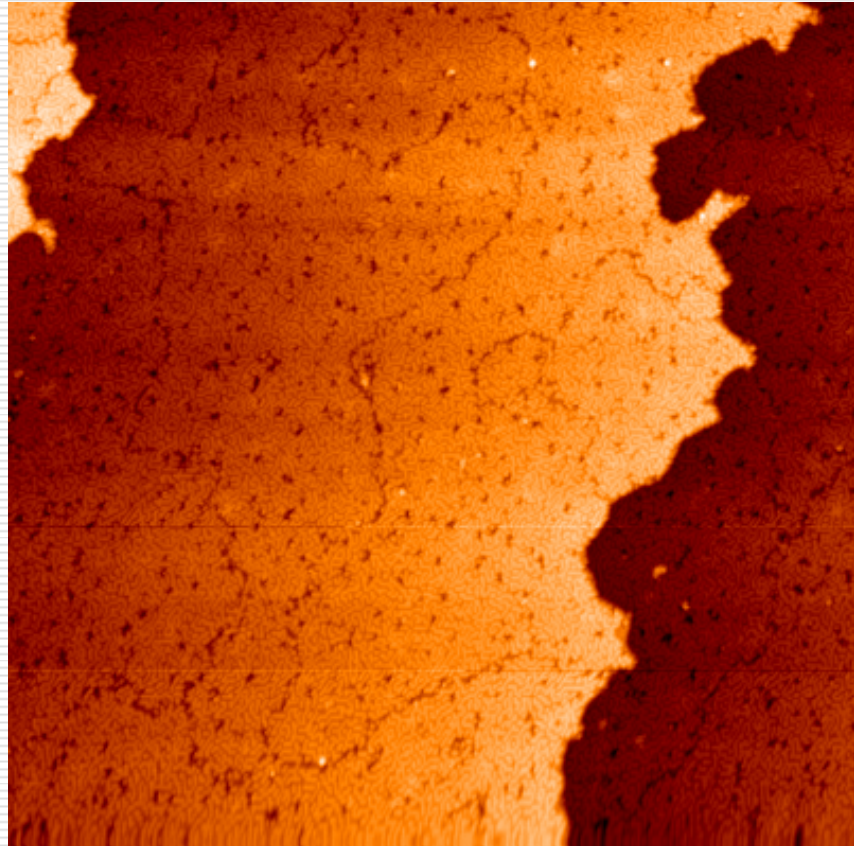


Pb/Si(111) 1/6ML: mosaic

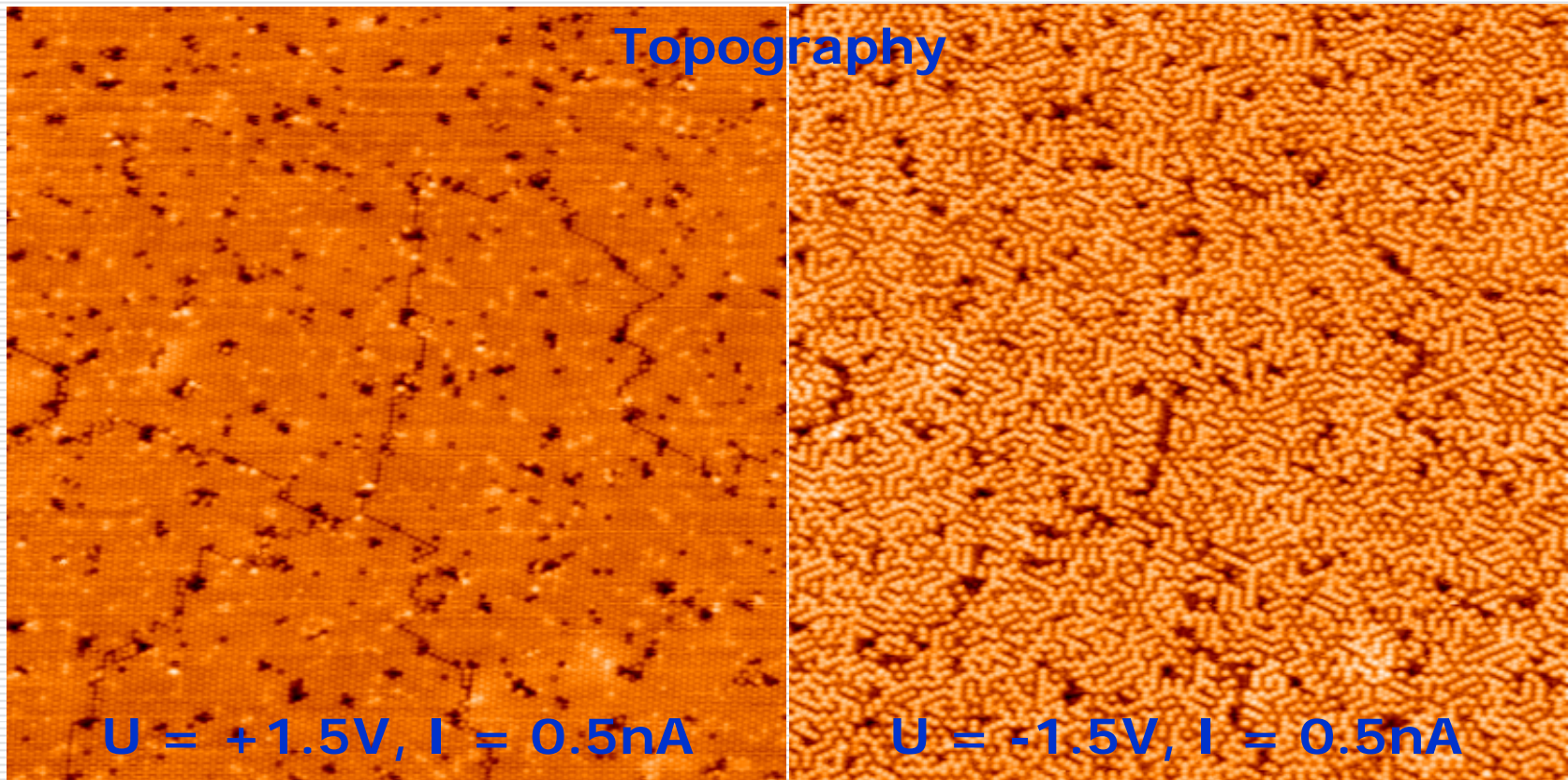
Pb evaporation on Si(111)-
7x7 + heating up to 700K

= mosaic structure

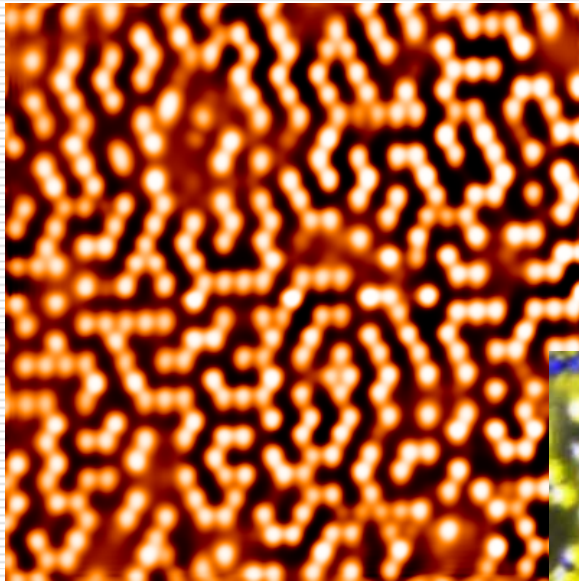
U=-1.5V, I=0.5nA,
standard topography,
size of 200x200 nm²



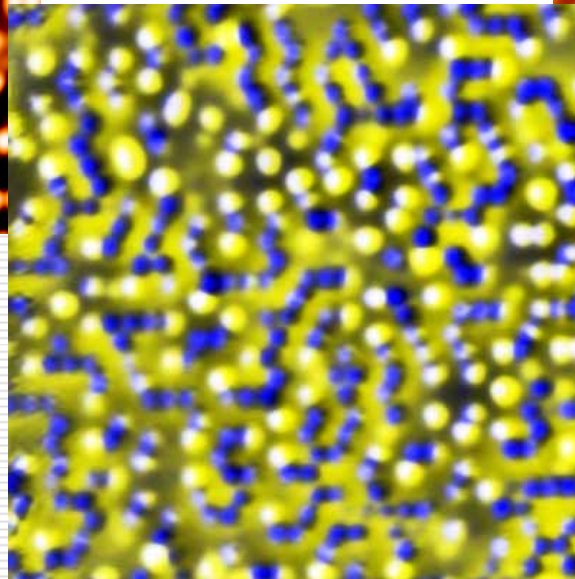
Mosaic: 100x100nm²



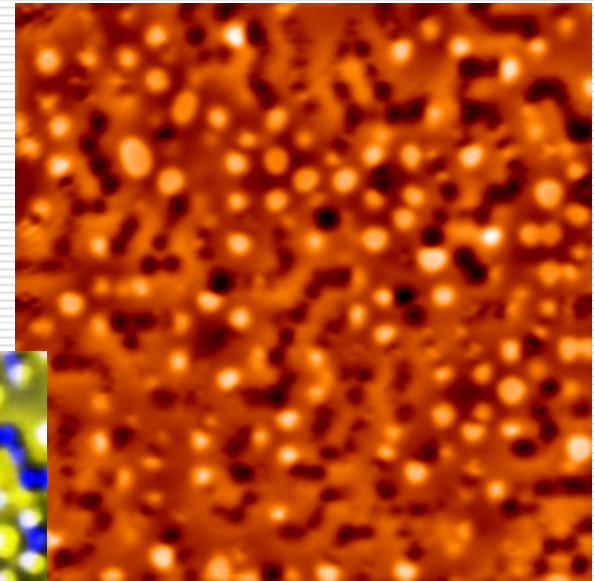
Mosaic: LDOS study



Current image,
 $U = -1.0V$,
blue channel



Combined image



Lock-in image at
 $U = -1.0V$,
red and green
(=yellow) channel

Summary & Conclusion

Real-space LDOS probing

- sensitive to chemical states, even of identical atoms
- distinguishes different species
- provides a complete view of system's electronic behaviour
[...nanoelectronics](#)
- a complementary method to angle-resolved photoemission
- at most localized among other methods

Outlook:

- co-adsorbed systems LDOS (improved atom identification)
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